





**Report Title:** Wilmington Capping  $i MEMS^{\otimes}$  -

ADXR620

**Report Number: 7505** 

**Revision:** A

Date: 17 September 2009



#### **Summary**

This report documents the successful completion of the reliability qualification requirements for release of the Wilmington Capping Process. The ADXRS620 product in a 32-CBGA package was used as the qualification vehicle. The ADXRS620 is a Capped whitespace version of XRS610.

**Table 1: ADXRS620 Product Characteristics** 

#### Die/Fab

Maximum Power Dissipation (W)	0.017
Device / Die ID	GC620R10
Die Size (mm)	3.44 x 3.40
Wafer Fabrication Site	I_WILM1B06
Wafer Fabrication Process	iMEMS3
Transistor Count	400
Passivation Layer	doped-oxide/SiN
Bond Pad Metal Composition	AlCu

#### Package/Assembly

Available Package	32-CBGA
Body Size (mm)	7.00 x 7.00 x 2.70
Lead Pitch (mm)	0.8
Operating Temperature Range	-55°C ≤ TA ≤ +125°C
Assembly Location	Amkor-P
Molding Compound	NA
Wire Type	Aluminum
Wire Diameter (mils)	1.25
Die Attach	Sumioxy 700
Maximum Peak Reflow Temperature (°C)	260



## **Description / Results of Tests Performed**

Tables 2 and 3 provide a description of the qualification tests conducted and the associated test results for products manufactured on the same technologies as described in Table 1. All devices were electrically tested before and after each stress. Any device that did not meet all electrical data sheet limits following stressing would be considered a valid (stress-attributable) failure unless there was conclusive evidence to indicate otherwise.

**Table 2: Package Qualification Test Results** 

Test Name	Specification	Conditions	Device	Package	Lot #	Sample	Qty.
TCSt Hame	opecinication	Conditions	Device	1 ackage	LOT #	Size	Failures
		Sub 4, MEMS Gyro,		Amkor-P 32-CBGA	Q7505.1	15	0
		Shock/Vib./Cent-	ADXRS620	Amkor-P	Q7505.18	15	0
	MII CTD 002	10kg/Seal Single		32-CBGA	Q7505.2	15	0
Group D <sup>1</sup>	MIL-STD-883, M5005	Duration		32-CBGA	Q7505.3	15	0
	MISOUS	Sub 6 Booidual			Q7505.19	3	0
		Sub 6, Residual Gas Analysis	ADXRS620	Amkor-P	Q7505.4	3	0
		Single Duration	ADAR3020	32-CBGA	Q7505.5	3	0
		Single Duration			Q7505.6	3	0
High Temperature Storage Life (HTSL) <sup>1</sup>	JESD22-A103	150°C 1,000 hours	ADXRS620	Amkor-P 32-CBGA	Q7505.14	77	0
Mechanical	IEC 68 Part 2- 27 Testgroup Ea	2000g, 5 shock pulses, 0.5ms Single Duration	ADXRS620	Amkor-P 32-CBGA	Q7505.20	10	0
Shock -					Q7505.7	10	0
Powered					Q7505.8	10	0
1 Oweled		Olligie Duration			Q7505.9	10	0
Random		10 drops from		Amkor-P	Q7505.10	45	0
Drop <sup>1</sup>	CAM0091	1.2m Single	ADXRS620	32-CBGA	Q7505.12	45	0
Бюр		Duration		32-CDGA	Q7505.21	45	0
Solder Heat				Amkor-P	Q7505.15	10	0
Resistance	ADI-0049	See Below	ADXRS620	32-CBGA	Q7505.16	10	0
(SHR) <sup>2,1</sup>				32-0DGA	Q7505.22	10	0
Temperature		-55°C / +125°C		Amkor-P	Q7505.17	77	0
Cycling	JESD22-A104		ADXRS620	32-CBGA	Q7505.23	77	0
(TC) <sup>2,1</sup>		1,000 cycles		32-CBGA	Q7505.24	77	0

<sup>1)</sup> Pre- and post-stress electrical test was performed at hot, ambient and cold temperatures.

These Samples were subjected to preconditioning (per J-STD-020 Level Other) prior to the start of the stress test. Preconditioning consists of the following: Reflow: 3 passes through an oven with a peak temperature of 260°C.



Test Name	Specification	Conditions	Device	Fab Process	Lot #	Sample Size	Qty. Failures
					Q7411.10	235	0
					Q7411.11	110	0
					Q7411.12	235	0
					Q7411.13	232	0
Early Life Failure Rate	MIL-STD-883, Method 1015	TA = 125°C 48 hours	ADXRS610	iMEMS3	Q7411.14	235	0
					Q7411.15	235	0
(ELFR)					Q7411.24	235	0
					Q7411.25	235	0
					Q7411.27	103	0
					Q7411.8	230	0
					Q7411.9	235	0
High		TA = 125°C <			Q7411.16	77	0
Temperature	JESD22-A108	Tj ∢ 135°C,	ADXRS610	iMEMS3	Q7411.17	77	0
Operating Life (HTOL) <sup>1</sup>	JESD22-A108	Biased 1,000 hours	ADVK2010	IIVIEIVISS	Q7411.18	77	0

**Table 3: Process Qualification Test Results** 

- 1) These Samples were subjected to preconditioning prior to the start of the stress test. The preconditioning consisted of Reflow: 3 passes through an oven with a peak temperature of 260°C.
- 2) ELFR tested at room and hot temperatures. HTOL tested at room, hot and cold temperatures.

Samples of the many devices manufactured with these package and process technologies are continuously undergoing reliability evaluation as part of the ADI Reliability Monitor Program. Additional qualification data is available on Analog Devices' web site.

#### **ESD Test Results**

The results of ESD testing are summarized in the ESD Results Table. All parts were electrically tested at room and hot temperatures pre- and post-stress. ADI measures ESD results using stringent test procedures based on the specifications listed in Table 4. Any comparison with another supplier's results should ensure that the same ESD test procedures have been used. For further details, please see the EOS/ESD chapter of the ADI Reliability Handbook (available via the 'Quality and Reliability' link at <a href="http://www.analog.com">http://www.analog.com</a>).

**Table 4: ESD Test Results** 

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ESD Model	Package	ESD Test Spec	RC Network	Highest Pass Level	First Fail Level	Class				
FICDM <sup>1</sup>	32-CBGA	ANSI/ESD STM5.3.1- 1999	1Ω, Cpkg	±250V	±500V	СЗ				
HBM <sup>1</sup>	32-CSP_BGA	ESD Assoc. STM5.1-2007	1.5kΩ, 100pF	±1500V	±2000V	Class 1				
MM <sup>1</sup>	32-CSP_BGA	ANSI/ESD STM5.2-1999	0Ω, 200pF	±100V	±200V	M2				

1) Pre- and post-stress electrical test was performed at ambient and hot temperatures.



## **Latch-Up Test Results**

Six samples of the ADXRS610 were Latch-up tested at Ta=125°C per JEDEC Standard JESD78, Class II, Level A. All six devices passed.

## **Approvals**

Reliability Engineer: Denis Belisle This report has been approved by electronic means (4.0)

#### **Additional Information**

Data sheets and other additional information are available on Analog Devices' web site: <a href="http://www.analog.com">http://www.analog.com</a>

#### **Appendix**

A: Bond Pull Data



# **Appendix A: Bond Pull Data**

# **Bond Pull Data Post 1000 Temperature Cycles Minimum Pull Strength after Temperature Cycle > 3 grams**

Readings are in GramForce Units.											
ADXRS610 RQ7411.1											
Unit		1		2	3		4		5		
Ball	Pull	Mode									
1	6.90	В	6.65	С	8.35	С	6.10	В	7.90	В	
2	5.20	В	6.75	В	7.30	В	6.30	В	9.10	В	
3	7.75	С	5.10	В	7.70	В	6.05	В	5.10	В	
4	7.00	В	6.20	В	8.30	С	7.60	С	7.10	В	
5	7.45	С	5.85	В	7.50	В	6.45	В	4.85	В	
6	6.55	В	8.65	D	8.25	С	7.20	В	7.30	В	
7	7.35	В	7.25	D	6.55	В	7.60	В	5.95	В	
8	6.50	С	5.25	В	7.45	В	8.35	С	6.50	В	
9	6.30	С	6.90	В	7.35	В	6.90	В	6.25	В	
10	5.55	В	7.55	В	5.95	В	6.10	В	7.20	В	
11	6.90	В	6.95	С	7.15	С	7.55	В	8.95	В	
12	5.75	В	7.30	В	8.05	В	5.95	В	7.40	С	
13	5.40	В	7.85	С	7.40	С	6.95	В	6.35	В	
14	6.55	С	6.40	В	6.40	D	8.00	В	6.90	С	
15	5.40	В	7.25	В	8.30	С	7.00	С	7.75	В	
16	5.50	В	7.70	В	6.40	В	5.50	В	7.70	В	
Min	5	5.20	5	5.10		5.95	5	5.50	4	1.85	
Max	7	7.75	8.65		3	3.35	8.35		9.10		
Ave	6	6.38	6	6.85	7	7.40	6	6.85	7	7.02	
Stdev	(	).82	C	).94	(	).76	C	).82	1	1.18	



	ADXRS610 RQ7411.2											
Unit	1		2		3		4		5			
Ball	Pull	Mode	Pull	Mode	Pull	Mode	Pull	Mode	Pull	Mode		
1	6.30	В	5.95	В	7.65	В	7.00	В	7.55	В		
2	5.85	В	6.85	В	7.10	В	6.90	В	7.30	В		
3	6.40	В	4.90	В	7.05	В	5.85	В	6.65	В		
4	6.90	В	5.80	В	7.40	В	6.50	В	6.70	В		
5	5.90	В	6.10	В	6.75	В	5.40	В	5.80	В		
6	5.75	В	6.85	С	6.85	В	6.20	В	5.60	В		
7	6.45	В	6.35	В	6.50	В	7.05	С	6.00	В		
8	6.70	D	5.55	В	5.65	D	6.02	В	6.10	В		
9	7.60	С	6.90	В	6.55	В	7.40	В	7.00	В		
10	6.90	В	6.10	В	7.15	В	5.80	В	5.85	В		
11	6.35	В	5.85	В	5.60	В	4.80	В	4.05	В		
12	5.64	В	5.40	В	5.35	В	4.65	В	5.85	В		
13	7.70	С	5.70	В	6.10	В	5.95	В	6.20	В		
14	6.55	В	5.85	В	5.25	В	6.40	В	5.40	В		
15	6.90	D	6.15	В	6.70	В	5.40	В	6.00	В		
16	6.90	В	4.70	В	6.95	В	6.90	В	5.45	В		
Min	5.	5.64 4.70		70	Ę	5.25	4.65		4.	05		
Max	7.70		6.	90	7	7.65		7.40		7.55		
Ave	6.	55	5.	94	(	6.54	6.14		6.09			
Stdev	0.	60	0.	63	(	).74	0.	81	0.84			



	ADXRS610 RQ7411.3										
Unit		1	2		3		4		5		
Ball	Pull	Mode	Pull	Mode	Pull	Mode	Pull	Mode	Pull	Mode	
1	4.90	В	6.15	В	6.65	С	5.90	В	6.20	В	
2	4.80	В	7.80	D	5.65	В	7.20	В	5.40	В	
3	5.25	В	6.20	В	7.05	В	5.30	В	6.00	В	
4	5.25	В	6.20	В	5.50	В	5.15	В	5.40	В	
5	6.90	В	6.75	В	6.95	С	7.30	В	6.15	В	
6	6.90	В	5.85	В	7.50	С	6.45	В	7.75	В	
7	6.75	В	5.70	В	6.30	В	6.55	В	6.55	В	
8	5.35	В	7.05	В	5.25	В	5.70	D	6.10	В	
9	6.50	В	5.65	В	6.50	В	6.35	В	6.20	В	
10	5.30	В	4.80	В	5.10	В	5.35	В	7.50	В	
11	5.90	В	5.70	В	7.55	С	5.20	В	7.00	С	
12	5.00	В	4.70	В	7.25	В	6.25	В	7.00	В	
13	5.40	В	5.80	В	7.30	В	7.10	В	5.90	D	
14	6.20	В	5.15	D	5.70		6.05	В	6.15	D	
15	4.80	В	5.15	В	7.75	С	5.60	В	5.70	В	
16	6.15	В	5.55	В	6.45	С	5.55	В	6.30	В	
Min	4.80		4	4.70		5.10		5.15		5.40	
Max	6.90		7	7.80	7	7.75		7.30		7.75	
Ave	5	5.71	5	5.89	6	6.53	6.06		6.33		
Stdev	C	).76	C	).81	C	).87	0.72		0.68		



